

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S145	18333	(burn-in or burn\$in)	US-PGPUB; USPAT; USOCR; FPRS	OR	ON	2008/03/20 15:43
S146	1727	(burn-in or burn\$in) probe	US-PGPUB; USPAT; USOCR; FPRS	SAME	ON	2008/03/20 15:43
S147	273	(burn-in or burn\$in) probe wire	US-PGPUB; USPAT; USOCR; FPRS	SAME	ON	2008/03/20 15:43
S148	23	(burn-in or burn\$in) probe wire and 438/612.ccls.	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/20 15:49
S149	115	probe wire and 438/612.ccls.	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/20 15:50
S150	8	("5330878"   "6144102"   "6310390"   "6329222").PN. OR ("6780748").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/03/20 15:53
S151	1	"20060258135"	US-PGPUB; USPAT; USOCR	OR	ON	2008/03/20 15:55
S152	380	257/e27.105.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2008/03/20 15:55
S153	1486	two adj (wires) (bump or ball or probe)	US-PGPUB; USPAT; USOCR; FPRS	SAME	ON	2008/03/20 17:17
S154	543	two adj (wires) (bump or ball or probe)	US-PGPUB; USPAT; USOCR; FPRS	WITH	ON	2008/03/20 17:17
S155	12	chip area reduc\$4 burn- in two adj(wires or connections or electrodes or wir\$3)one adj(bump or probe)	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:00
S156	172	chip area reduc\$4 burn- in two adj(wires or connections or electrodes or wir\$3) (bump or probe)	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:15
S157	0	chip with area with reduc\$4 with burn-in two adj(wires or connections or electrodes or wir\$3) (bump or probe)	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:18

S158	0	chip with area with reduc\$4 same burn-in two adj(wires or connections or electrodes or wir\$3) (bump or probe)	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:19
S159	8	chip with area with reduc\$4 burn-in two adj (wires or connections or electrodes or wir\$3) (bump or probe)	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:19
S160	102	chip with area with reduc\$4 test\$3 two adj (wires or connections or electrodes or wir\$3) (bump or probe)	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:26
S161	26	chip with area with reduc\$4 test\$3 two adj (wires or connections or electrodes or wir\$3) same (bump or probe)	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:27
S162	32	two adj(wires or connections or electrodes or wir\$3) same (bump or probe) and 438/14-18.ccls.	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:30
S163	43	two adj(lines or wires or connections or electrodes or wir\$3) same (bump or probe) and 438/14-18.ccls.	US-PGPUB; USPAT; USOCR; FPRS	AND	ON	2008/03/24 10:31
S164	46	two adj(lines or wires or connections or electrodes or wir\$3) same (bump or probe) and 438/14-18.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2008/03/24 10:31
S165	93197	disconnect\$3 (wir\$3 or connect\$3 or lines) (pads or contacts)	US-PGPUB; USPAT; USOCR; FPRS	SAME	ON	2008/03/24 11:22
S166	28146	disconnect\$3 (wir\$3 or connect\$3 or lines) (pads or contacts)	US-PGPUB; USPAT; USOCR; FPRS	WITH	ON	2008/03/24 11:26
S167	853	disconnect\$3 (wir\$3 or connect\$3 or lines) (pads or contacts)	US-PGPUB; USPAT; USOCR; FPRS	NEAR	ON	2008/03/24 11:26

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